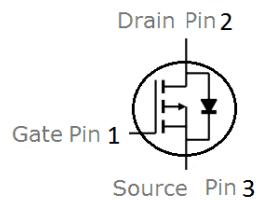
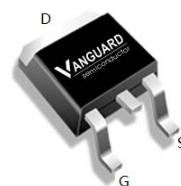


Features

- P-Channel, -5V Logic Level Control
- Enhancement mode
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=-4.5\text{ V}$
- Fast Switching
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant

V_{DS}	-40	V
$R_{DS(on),TYP}$ @ $V_{GS}=-10\text{ V}$	7	$\text{m}\Omega$
$R_{DS(on),TYP}$ @ $V_{GS}=-4.5\text{ V}$	10	$\text{m}\Omega$
I_D	-90	A

TO-252


Part ID	Package Type	Marking	Tape and reel information
VS4504AD	TO-252	4504AD	2500PCS/Reel

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	-40	V
I_s	Diode continuous forward current	$T_c=25\text{ }^\circ\text{C}$	A
I_D	Continuous drain current @ $V_{GS}=-10\text{V}$	$T_c=25\text{ }^\circ\text{C}$	A
		$T_c=100\text{ }^\circ\text{C}$	-64
I_{DM}	Pulse drain current tested ①	$T_c=25\text{ }^\circ\text{C}$	A
EAS	Avalanche energy, single pulsed ②	163	mJ
P_d	Maximum power dissipation	$T_c=25\text{ }^\circ\text{C}$	W
V_{GS}	Gate-Source voltage	± 20	V
$T_{STG} T_J$	Storage and operating temperature range	-55 to 175	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance-Junction to Case	1.5	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	100	$^\circ\text{C/W}$

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-40	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-1	μA
	Zero Gate Voltage Drain Current($T_J=125^\circ\text{C}$)	$V_{\text{DS}}=-40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1.3	-1.6	-2.4	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ③	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-20\text{A}$	--	7	9	$\text{m}\Omega$
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ③	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-15\text{A}$	--	10	13	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	4600	5120	5600	pF
C_{oss}	Output Capacitance		400	490	600	pF
C_{rss}	Reverse Transfer Capacitance		300	415	510	pF
R_g	Gate Resistance	$f=1\text{MHz}$		7.7		Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=-20\text{V}, I_{\text{D}}=-20\text{A}, V_{\text{GS}}=-10\text{V}$	--	85	--	nC
Q_{gs}	Gate-Source Charge		--	17	--	nC
Q_{gd}	Gate-Drain Charge		--	20	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=-20\text{V}, I_{\text{D}}=-20\text{A}, R_{\text{G}}=3.0\Omega, V_{\text{GS}}=-10\text{V}$	--	19.5	--	nS
t_r	Turn-on Rise Time		--	22	--	nS
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	85.5	--	nS
t_f	Turn-Off Fall Time		--	39	--	nS
Source- Drain Diode Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=-20\text{A}, V_{\text{GS}}=0\text{V}$	--	-0.8	-1.2	V
t_{rr}	Reverse Recovery Time	$T_J=25^\circ\text{C}, I_{\text{SD}}=-20\text{A}, V_{\text{GS}}=0\text{V}, \frac{dI}{dt}=-500\text{A}/\mu\text{s}$	--	29	--	nS
Q_{rr}	Reverse Recovery Charge			167		nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

② Limited by $T_{J\text{max}}$, starting $T_J = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = -20\text{A}$, $V_{GS} = -10\text{V}$. Part not recommended for use above this value

③ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

Typical Characteristics

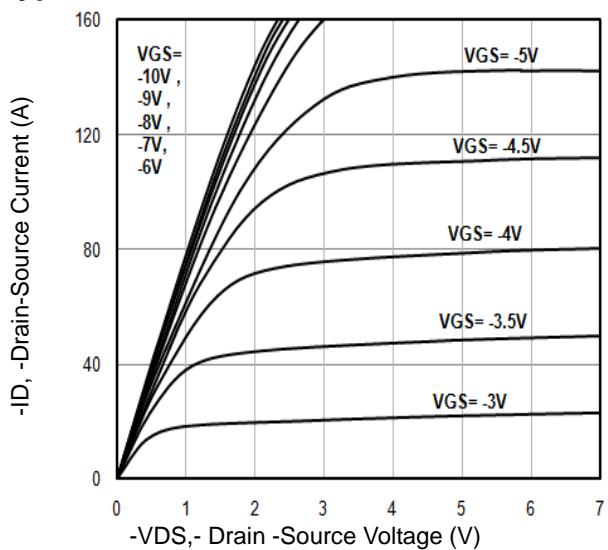


Fig1. Typical Output Characteristics

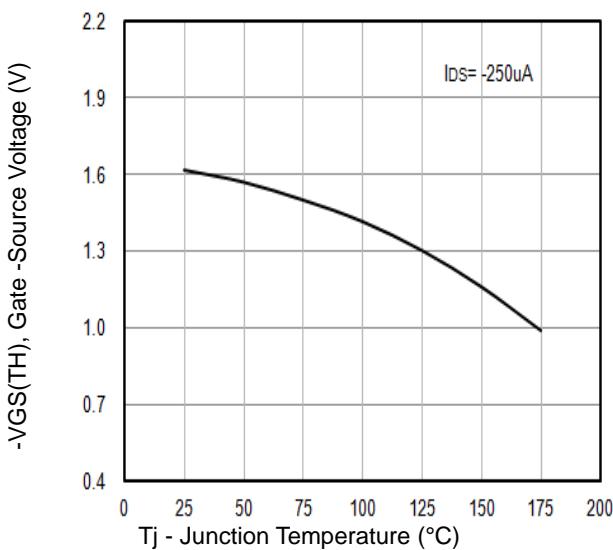


Fig2. $-V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

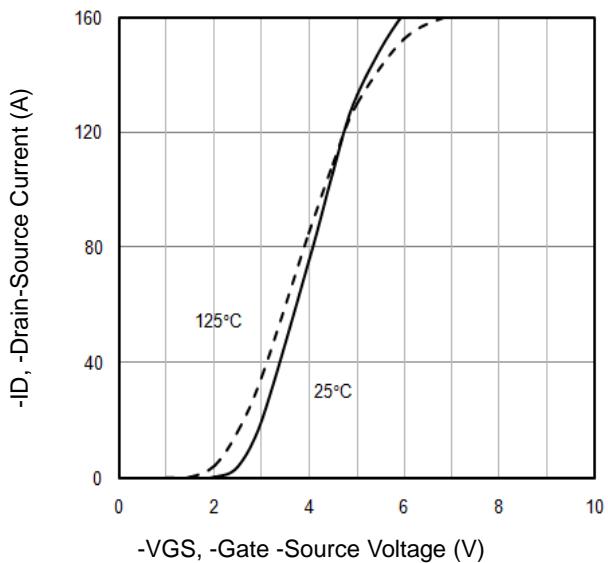


Fig3. Typical Transfer Characteristics

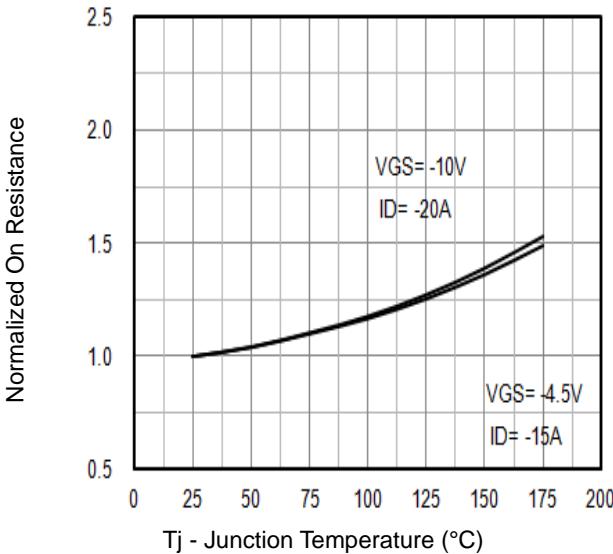


Fig4. Normalized On-Resistance Vs. T_j

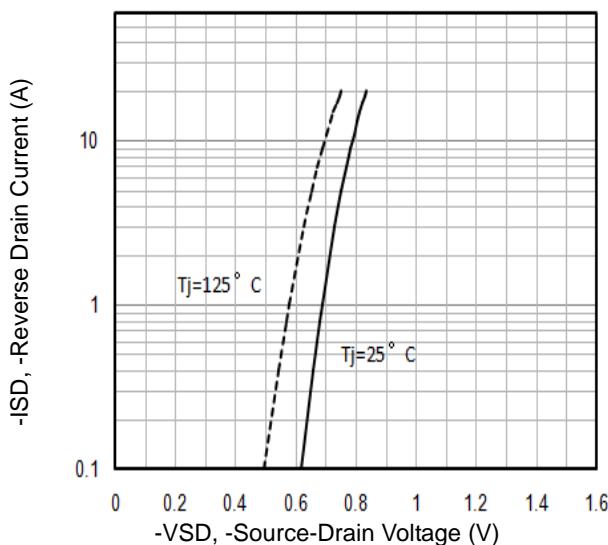


Fig5. Typical Source-Drain Diode Forward Voltage

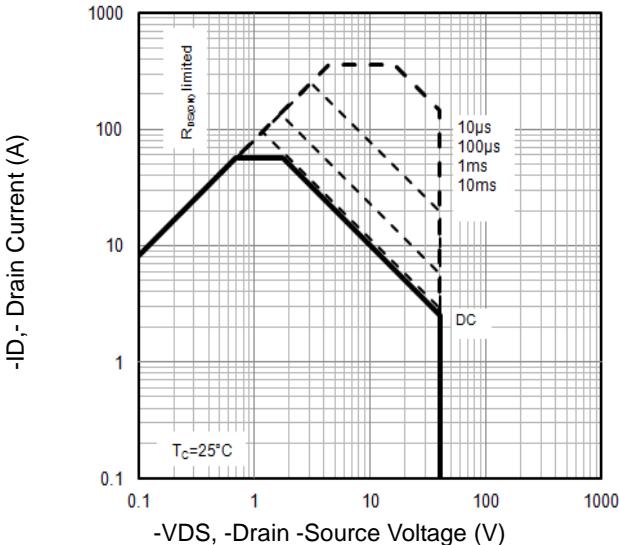


Fig6. Maximum Safe Operating Area

Typical Characteristics

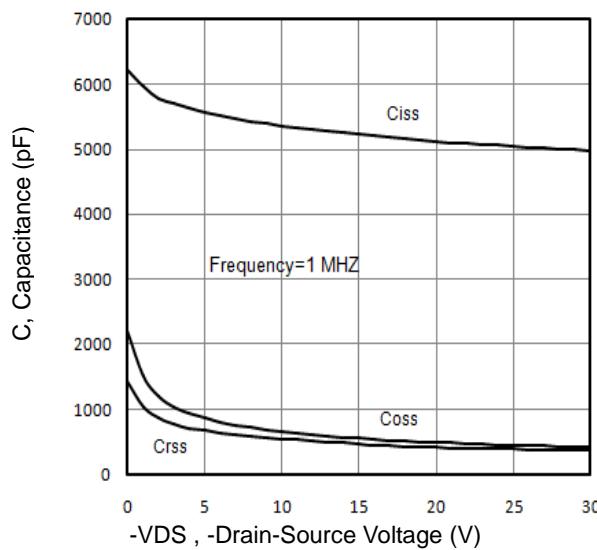


Fig7. Typical Capacitance Vs.Drain-Source Voltage

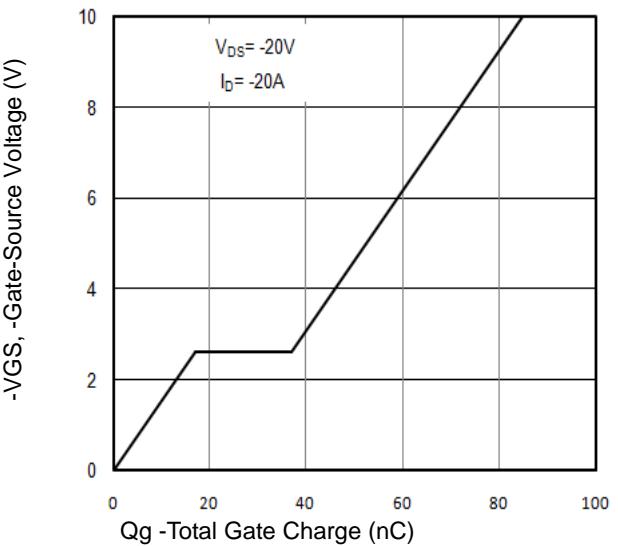


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

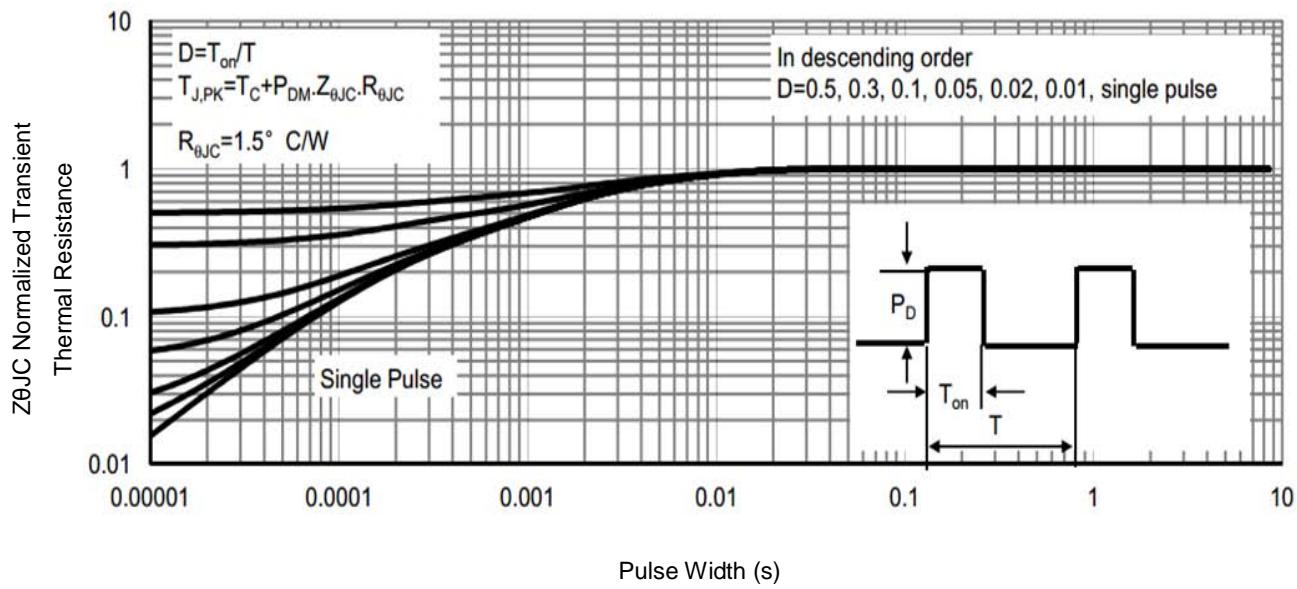


Fig9. Normalized Maximum Transient Thermal Impedance

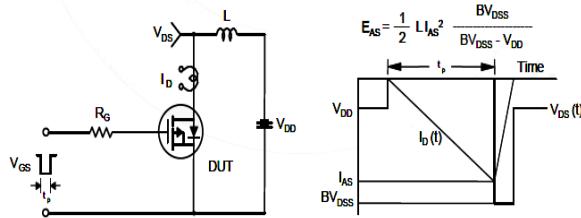


Fig10. Unclamped Inductive Test Circuit and Waveforms

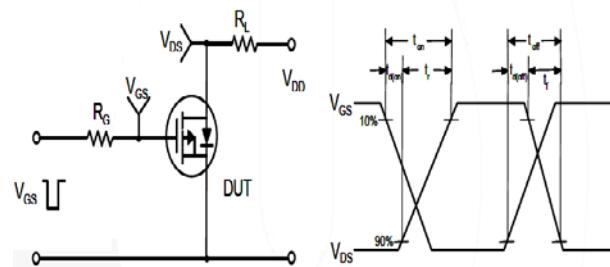
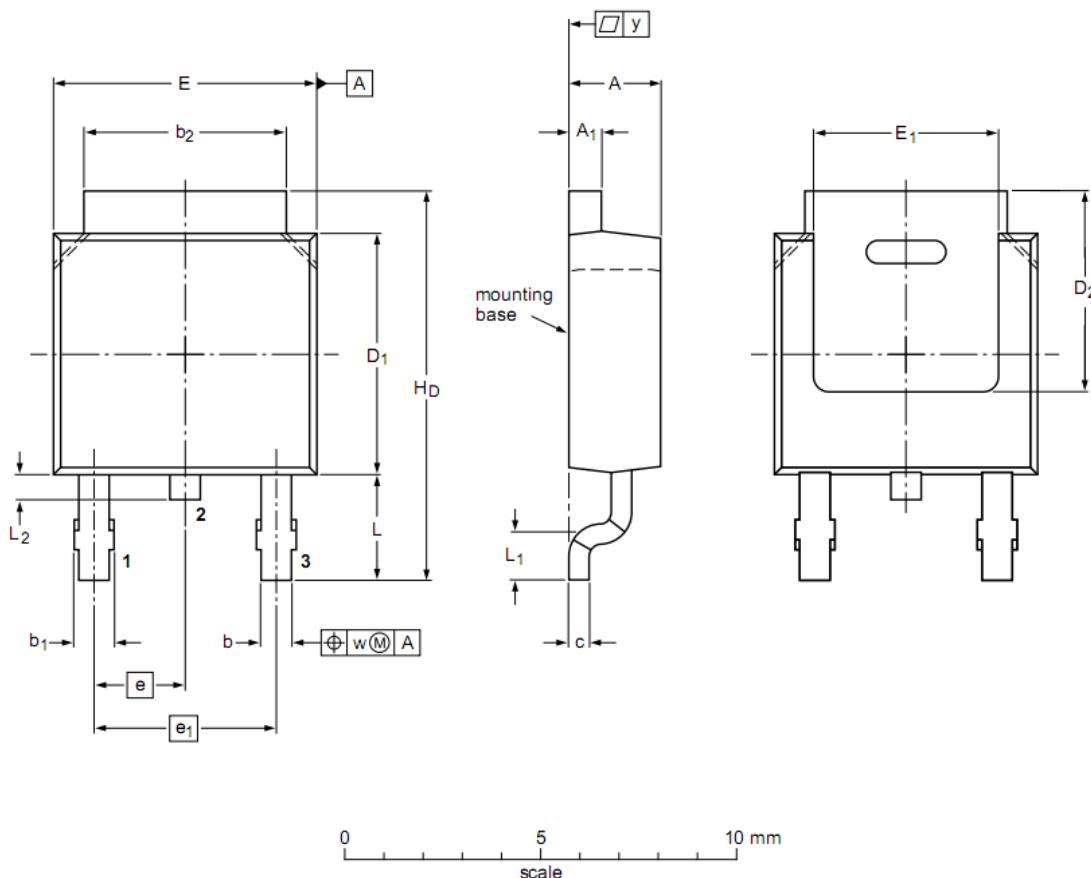


Fig11. Switching Time Test Circuit and waveforms

TO-252 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	2.20	2.30	2.38
A ₁	0.46	0.50	0.63
b	0.64	0.76	0.89
b ₁	0.77	0.85	1.14
b ₂	5.00	5.33	5.46
c	0.458	0.508	0.558
D ₁	5.98	6.10	6.223
D ₂	5.21	--	--
E	6.40	6.60	6.731
E ₁	4.40	--	--
e	2.286 BSC		
e ₁	--	4.57	--
H _b	9.40	10.00	10.40
L	2.743 REF		
L ₁	1.40	1.52	1.77
L ₂	0.50	0.80	1.01
w	--	0.20	--
y	--	--	0.20

Notes:

- Refer to JEDEC TO-252 variation AA
- Dimension "E" does NOT include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.1524mm per side.
- Dimension "D₁" does NOT include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.1524mm per end.

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